**ON Semiconductor** 

Is Now

# Onsemi

To learn more about onsemi<sup>™</sup>, please visit our website at <u>www.onsemi.com</u>

onsemi and ONSEMI. and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product factures, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and asfety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or by customer's technical experts. onsemi products and actal performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use onsemi products for any such unintended or unauthorized application, Buyer shall indemnify and hold onsemi and its officers, employees, subsidiari

# <u>MOSFET</u> - Power, Dual N- & P-Channel, μ8FL

# 100 V, 70 mΩ, 9.5 A, -100 V, 186 mΩ, -5 A

# NTTBC070NP10M5L

#### Features

- Small Footprint (3 x 3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$  and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- Motor Drive, Home Automation

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C, Unless otherwise specified)

Par	rameter		Symbol	Q1	Q2	Unit
Drain-to-Source Breakdown Voltage			V <sub>(BR)DSS</sub>	100	-100	V
Gate-to-Source \	/oltage		V <sub>GS</sub>	±20	±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady State	T <sub>C</sub> = 25°C	Ι <sub>D</sub>	9.5	-5	A
Power Dissipation $R_{\theta JC}$ (Note 2)			P <sub>D</sub>	14	10	W
Continuous Drain Current R <sub>θJA</sub> (Note 1, 2)	Steady State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	3.5	-2.2	A
Power Dissipation R <sub>0JA</sub> (Note 1, 2)			P <sub>D</sub>	1.9	1.9	W
Pulsed Drain Current	$T_{A} = 25^{\circ}C$	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		33	33	A
Operating Junctio perature Range	n and Stor	age Tem-	TJ, T <sub>stg</sub>	–55 to	+150	°C
Source Current (E	Source Current (Body Diode)			12	8	А
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 7.3 A, 7.8 A, L = 1 mH)			E <sub>AS</sub>	26	30	mJ
Lead Temperature Soldering Purpose (1/8" from case fo	es	Reflow for	TL	260	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.

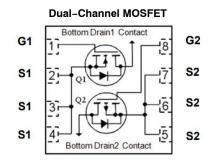
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

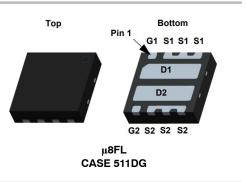


# **ON Semiconductor®**

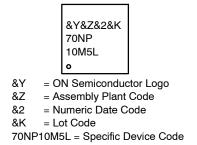
#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
100 V	70 mΩ @ 10 V	9.5 A
–100 V	186 m $\Omega$ @ 10 V	–5 A





#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{ ext{ heta}JC}$	Junction-to-Case - Steady State (Note 3)	8.9	12.5	°C/W
$R_{ hetaJA}$	Junction-to-Ambient – Steady State (Note 3)	65	65	

3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

#### **ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL)** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Condition	าร	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-				-	-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 25$	50 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	$I_D = 250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$			70		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				1	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 100 V	T <sub>J</sub> = 125°C			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = =	±20 V			±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	4 μ <b>A</b>	1.0		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> <sup>/</sup> T <sub>J</sub>	$I_D = 24 \ \mu A$ , ref to 2	25°C		7.1		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ V}$	1.3A		47	70	mΩ
		$V_{GS}$ = 4.5 V, I <sub>D</sub> =	1.0 A		67	102	1
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 5 V, I_D = 4 A$			6.2		S
Gate-Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			0.74		Ω
CHARGES & CAPACITANCES	•						•
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V			252		pF
Output Capacitance	C <sub>OSS</sub>				64		7
Reverse Transfer Capacitance	C <sub>RSS</sub>				3		
Total Gate Charge	Q <sub>G(TOT)</sub>				3		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.6		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 50 V	ν, I <sub>D</sub> = 1.3 A		1.0		1
Gate-to-Drain Charge	Q <sub>GD</sub>				1.1		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.6		
Plateau Voltage	V <sub>GP</sub>	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 50 V	, I <sub>D</sub> = 1.3 A		2.6		V
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t <sub>d(ON)</sub>				5.3		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V	, I <sub>D</sub> = 1.3 A.		2.5		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{\rm G} = 6 \Omega$			12.4		
Fall Time	t <sub>f</sub>				7.5		1
Turn-On Delay Time	t <sub>d(ON)</sub>				7.6		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V	, I <sub>D</sub> = 1.3 A.		7.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{\rm G} = 6 \Omega$	, u,		10.4		1
Fall Time	t <sub>f</sub>				9		1

#### ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit

OFF CHARACTERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V_{c}$	$T_J = 25^{\circ}C$	0.75	1.2	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.3 A	T <sub>J</sub> = 125°C	0.6		
Reverse Recovery Time	t <sub>RR</sub>		·	28		ns
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt =	13			
Discharge Time	t <sub>b</sub>	$V_{GS}$ = 0 V, dI <sub>S</sub> /dt = 50 A/µs, I <sub>S</sub> = 1.2 A		15		
Reverse Recovery Charge	Q <sub>RR</sub>			8		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = -250 $\mu$ A		-100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = –250 μA, ref tc	$I_D = -250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$		60		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V 0.V.V 400.V	$T_J = 25^{\circ}C$			-1	μA
		$V_{GS} = 0 V, V_{DS} = -100 V$	T <sub>J</sub> = 125°C			-100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V				±100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -4$	40 μA	-2.0		-4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> <sup>/</sup> T <sub>J</sub>	$I_D = -40 \ \mu A$ , ref to	25°C		6.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -	-2.2 A		146	186	mΩ
		$V_{GS} = -6 \text{ V}, \text{ I}_{D} = -1.4 \text{ A}$			178	284	
Forward Transconductance	9 <sub>FS</sub>	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = -4 \text{ A}$			5.9		S
Gate-Resistance	R <sub>G</sub>	$T_A = 25^{\circ}C$			1.75		Ω
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				256		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V	<sub>DS</sub> = -50 V		63		
Reverse Transfer Capacitance	C <sub>RSS</sub>				3		
Total Gate Charge	Q <sub>G(TOT)</sub>				7.3		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.5		
Gate-to-Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -50 \	/, I <sub>D</sub> = –2.2 A		2.4		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.2		
Total Gate Charge	Q <sub>G(TOT)</sub>				4.6		nC
Plateau Voltage	V <sub>GP</sub>	$V_{GS} = -6$ V, $V_{DD} = -50$ V, $I_{D} = -2.2$ A			4.5		V
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t <sub>d(ON)</sub>				8.9		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = -10 V, $V_{DS}$ = -50 V, $I_{D}$ = -2.2 A, $R_{G}$ = 6 $\Omega$			3.6		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_{G} = 6 \Omega$	, <b>D</b> ,		13.2		
Fall Time	t <sub>f</sub>	1			3.4		

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

ta

t<sub>b</sub>

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$ 

Charge Time

Discharge Time

Reverse Recovery Charge

Parameter	Symbol	Test Conditions		Min	Тур	Max	Unit
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = –6 V, $V_{DS}$ = –50 V, $I_{D}$ = –2.2 A, $R_{G}$ = 6 $\Omega$			10.8		ns
Rise Time	t <sub>r</sub>				4.8		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				10		
Fall Time	t <sub>f</sub>				4.1		
OFF CHARACTERISTICS							
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, \\ I_{S} = -2.2 A \\ T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$			-0.86	-1.2	V
					-0.72		
Reverse Recovery Time	t <sub>RR</sub>				34		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 $\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \, dI_S/dt = 100 \ \text{A}/\mu\text{s}, \\ I_S = -1.1 \ \text{A} \end{array}$ 

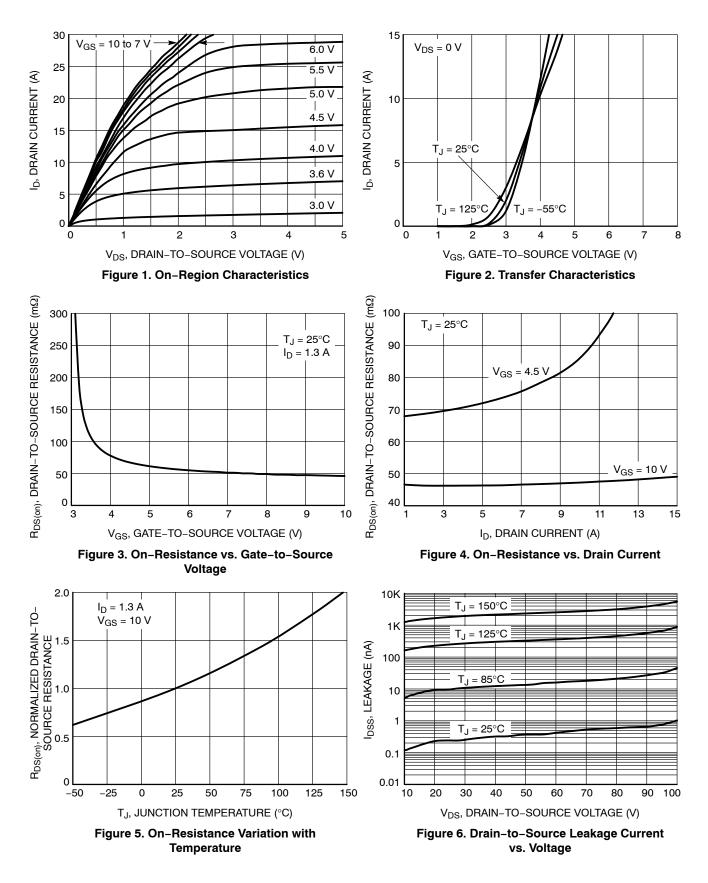
27

7

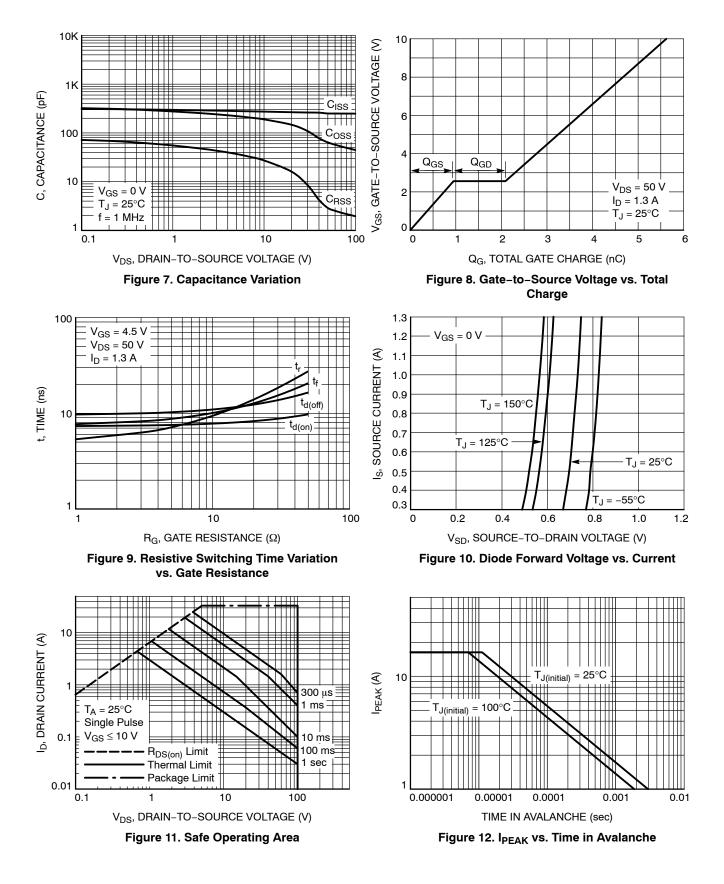
53

nC

#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**

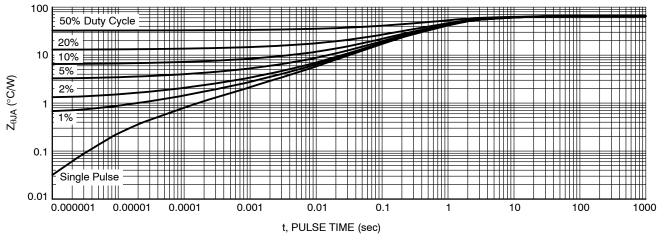
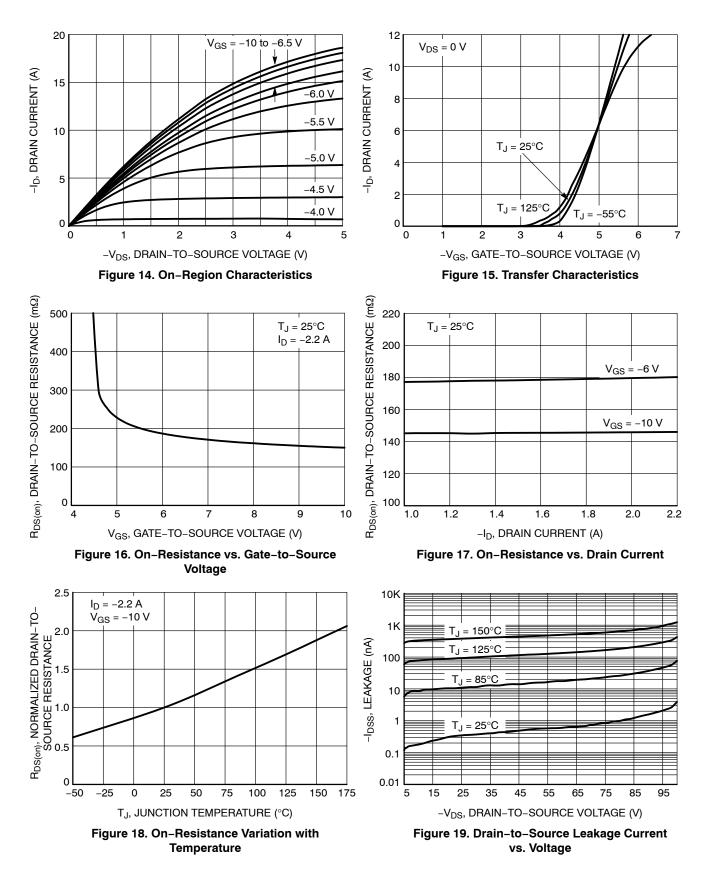
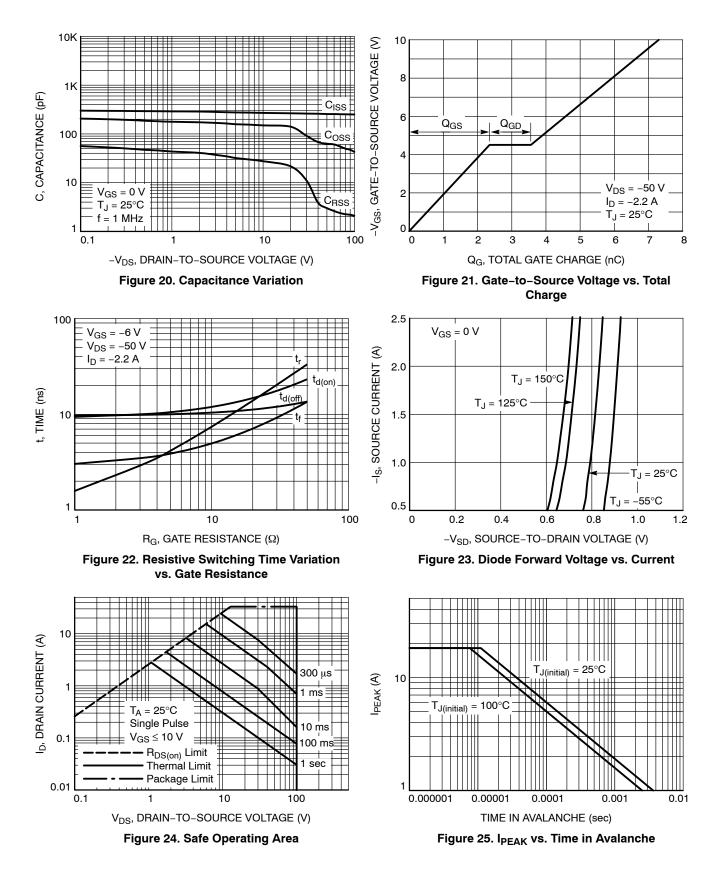


Figure 13. Junction-to-Ambient Transient Thermal Response

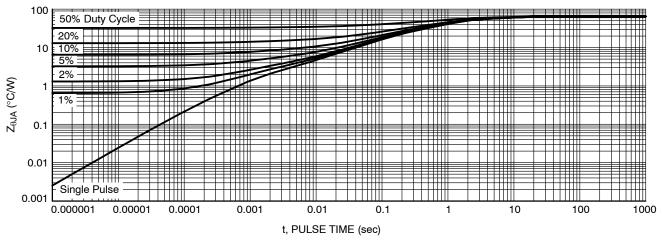
#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



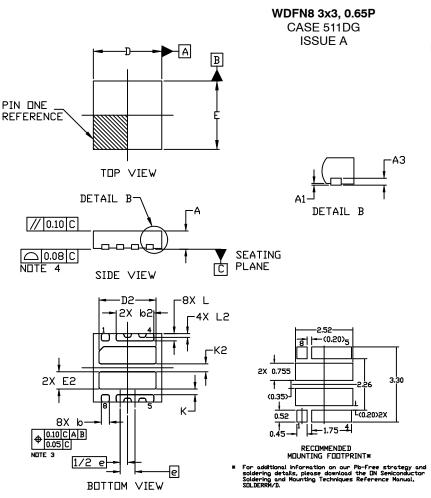


#### **ORDERING INFORMATION**

Device	Device Marking	Package	Shipping (Qty / Packing) $^{\dagger}$
NTTBC070NP10M5L	70NP10M5L	μ8FL (Pb–Free/Halogen Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



NDTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION & APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MI	MILLIMETERS				
DIM	MIN.	NDM.	MAX.			
A	0.70	0.75	0.80			
A1	0.00		0.05			
A3	-	0.20 REF	-			
b	0.30	0.35	0.40			
b2	1.65 REF					
D	2.90	3.00	3.10			
DS	2.45	2.50	2.55			
E	2.90	3.00	3.10			
E5	1.40	1.50	1.60			
e		0.65 BSC				
к	0.25					
K5	0.35 REF					
L	0.27	0.32	0.37			
L2	(	).163 REF	-			

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <u>www.onsemi.com/site/pdf/Patent-Marking.pdf</u>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use a a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiarie

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

#### TECHNICAL SUPPORT

ON Semiconductor Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800–282–9855 Toll Free USA/Canada Phone: 011 421 33 790 2910 Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative